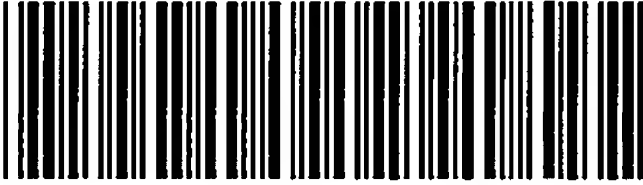


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/622,164	SAKAI ET AL.	
	Examiner	Art Unit	
	Leda T. Pham	2834	

SEARCHED			
Class	Subclass	Date	Examiner
310	239	3/11/2005	LP
310	71	3/11/2005	LP
310	242	3/11/2005	LP
310	248	3/11/2005	LP
310	249	3/11/2005	LP
310	89	3/11/2005	LP
310	40MM	3/11/2005	LP
310	68C	3/11/2005	LP

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
H02k011\$.ipc and brushes	3/11/2005	LP